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3629

[illegible]

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
US Patent, PG Pub	7/30/04	20h
Foreign		
Epo		
Jpo		
Derwent		
NPL (Dialog)		
1. Ftext		
2. Ftext2		
3. NFtext		